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PTO/SB/08A (10-01)

Approved for use through 10/31/2002, OMB 0651-0031

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Substitute for form 1449A/PTO				Complete If Known	
				Application Number	09/674,090
				Filing Date	March 1, 2001
				First Named Inventor	Yoav Eichen
				Art Unit	1637
				Examiner Name	Jeffrey Siew
Sheet	1	of	3	Attorney Docket Number	I8363.0002/P002

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Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)			
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		WO 99/04440	1-1999	WIPO	
		WO 99/29711	6-1999	WIPO	
		WO 99/35256	7-1999	WIPO	
		WO 99/36573	7-1999	WIPO	

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OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T ²
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		Mirkin et al., "A DNA-Based Method of Rationally Assembling Nanoparticles Into Macroscopic Materials", <i>Nature</i> , 382:607-609 (1996)			
		Alivisatos et al., "Organization of 'Nanocrystal Molecules' Using DNA," <i>Nature</i> , 382:609-11 (1996)			
		Braun et al., "DNA-Templated Assembly and Electrode Attachment of a Conducting Silver Wire," <i>Nature</i> , 391:775-778 (1998)			
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		Klein et al., "An Approach to Electrical Studies of Single Nanocrystals," <i>Appl. Phys. Lett.</i> , 68 (18):2574-2576 (1996)			
		Sato et al., "Single Electron Transistor Using A Molecularly Linked Gold Colloidal Particle Chain," <i>J. Appl. Phys.</i> 82 (2) : 696-701 (1997)			

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(use as many sheets as necessary)</i>				Application Number	09/674,090
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		Graber et al., "Kinetic Control of Interparticle Spacing in Au Colloid-Based Surfaces: Rational Nanometer-Scale Architecture," J. Am. Chem. Soc., 118:1148-1153 (1996)
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/Angela Bertagna/

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